

Notice of References Cited	Application/Control No. 10/766,808	Applicant(s)/Patent Under Reexamination YAMANAKA ET AL.	
	Examiner Dung (Michael) T. Nguyen	Art Unit 2828	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0090172 A1	07-2002	Okazaki et al.	385/27
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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